

[54] **CIRCUIT TESTER**

[75] Inventors: **Robert C. Cressman, E. Greenwich;
Joseph P. Stefani, Warwick, both of
R.I.**

[73] Assignee: **General Electric Company**

[**] Term: **14 Years**

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[51] Int. Cl. **D10-04**

[52] U.S. Cl. **D10/78**

[58] Field of Search **D10/75, 78, 79, 46;
340/641; 315/58, 71, 291; 324/51, 72.5, 73 R,
122, 133, 149, 156**

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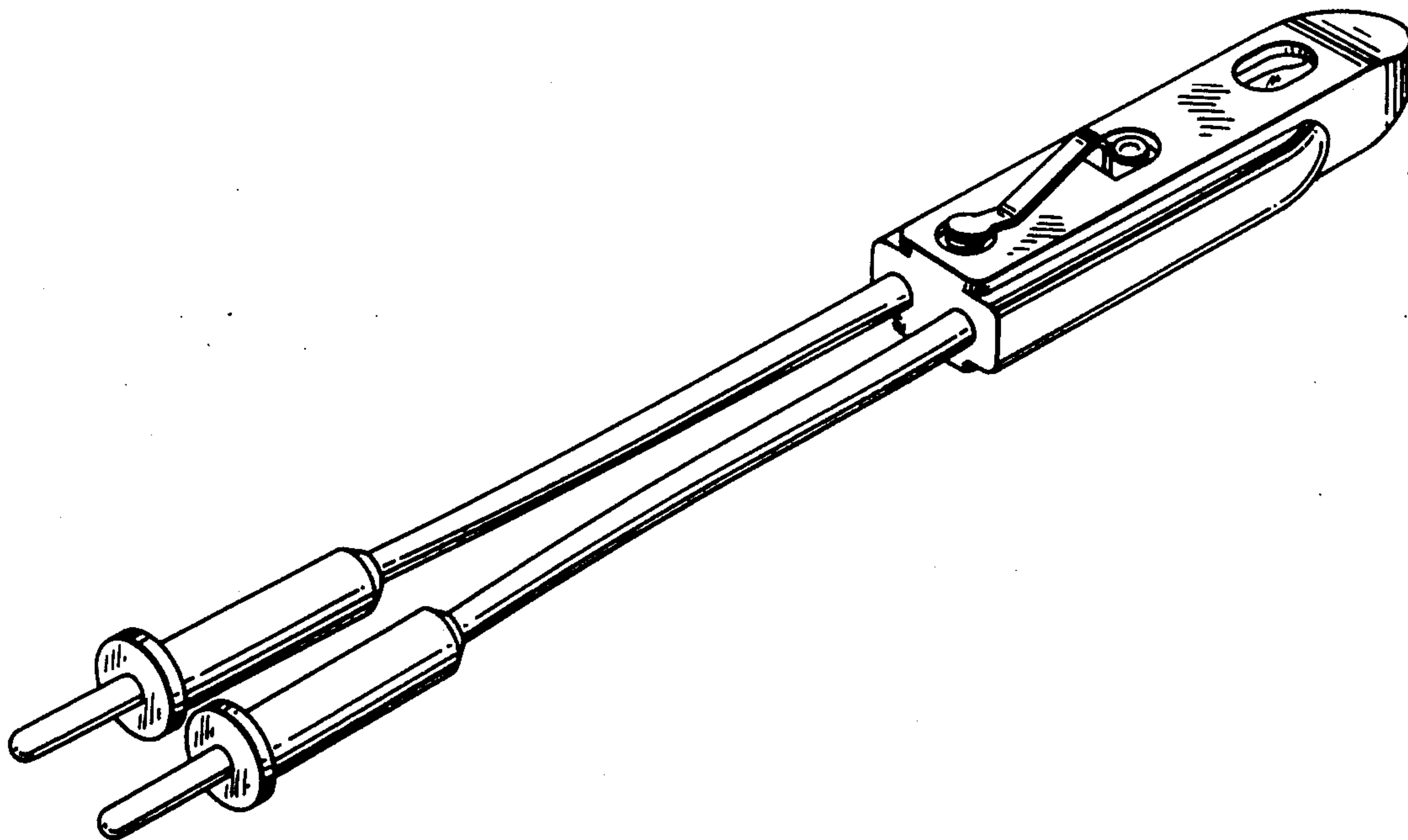
Primary Examiner—Nelson C. Holtje
Attorney, Agent, or Firm—P. E. Rochford

[57] **CLAIM**

The ornamental design for a circuit tester, as shown and described.

DESCRIPTION

FIG. 1 is a right front perspective view of a circuit tester showing our new design;
FIG. 2 is a front elevational view thereof;
FIG. 3 is a rear elevational view thereof;
FIG. 4 is a right side elevational view thereof, the left side being a mirror image thereto;
FIG. 5 is a bottom plan view thereof;
FIG. 6 is a top plan view thereof.



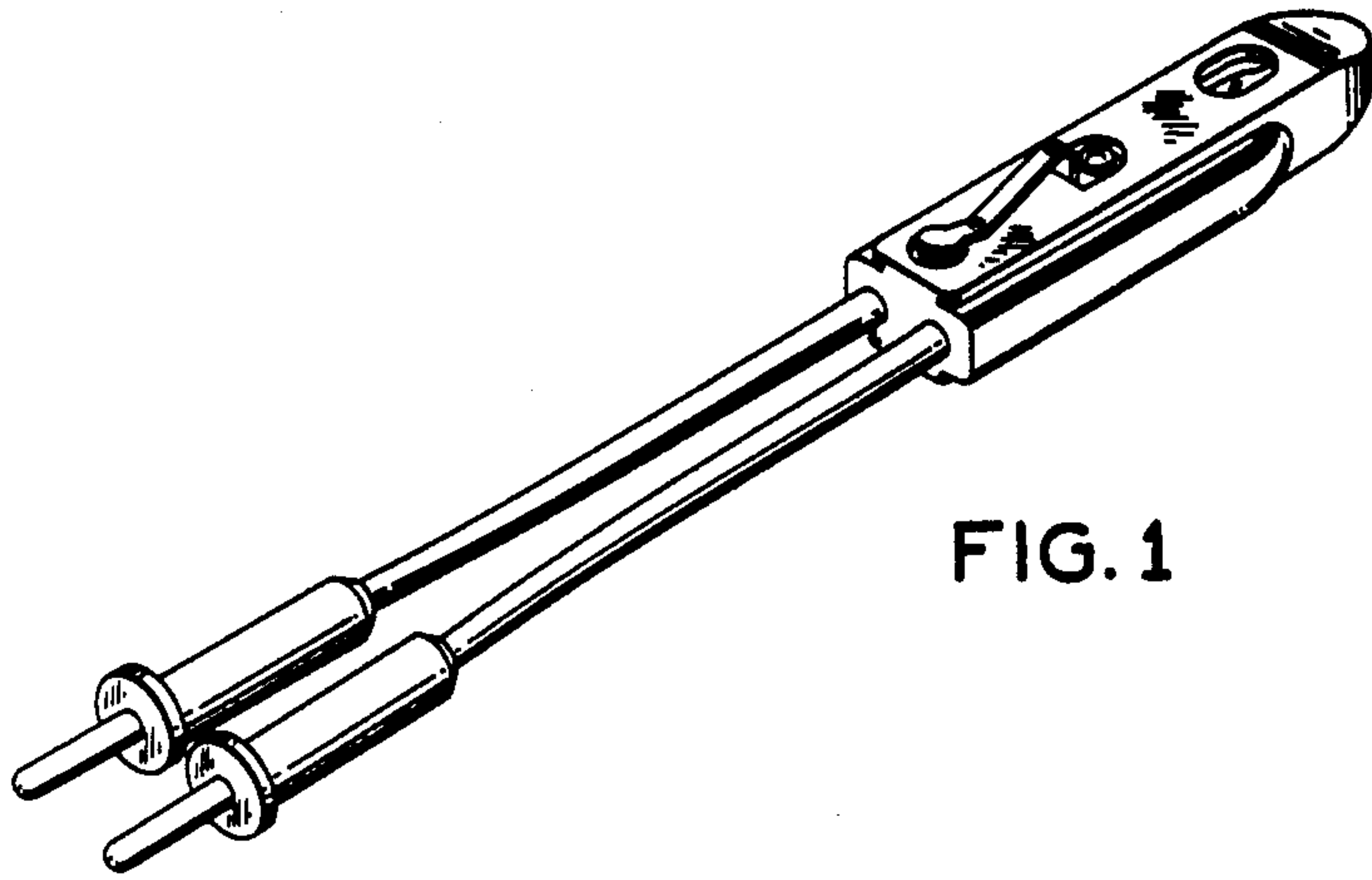


FIG. 1



FIG. 2

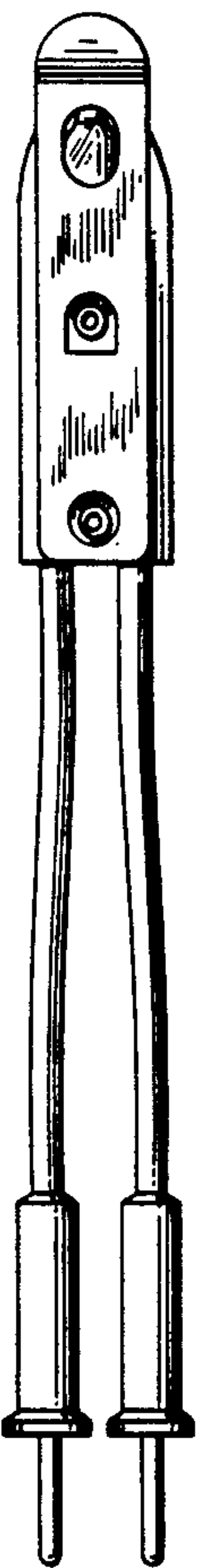


FIG. 3



FIG. 4

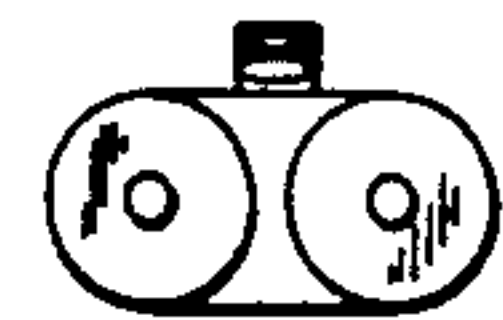


FIG. 5



FIG. 6